

<b>Notice of References Cited</b>	Application/Control No. 09/755,581	Applicant(s)/Patent Under Reexamination MIYAKE ET AL.	
	Examiner Benjamin R. Bruckart	Art Unit 2155	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,012,088	01-2000	Li et al.	709/220
*	B	US-6,130,892	10-2000	Short et al.	370/401
*	C	US-6,427,170	07-2002	Sitaraman et al.	709/226
*	D	US-5,872,928	02-1999	Lewis et al.	709/221
*	E	US-6,796,494	09-2004	Gonzalo, Steven M.	235/380
*	F	US-6,161,133	12-2000	Kikinis, Dan	709/220
*	G	US-2002/0010767	01-2002	FARROW et al.	709/223
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.